

Search Notes



Application/Control No.

10/621,970

Examiner

Mark K. Han

Applicant(s)/Patent under Reexamination

GRAF ET AL.

Art Unit

3767

SEARCHED

Class	Subclass	Date	Examiner
604	131 134	9/5/2006	msh
	135 187		
	207 208		
	209 210		
	211 218		
	224		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
inventor name search	3/16/2006	msh.
EAST text search	9/5/2006	msh.